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### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Obsolete
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	120MHz
Connectivity	I <sup>2</sup> C, SPI, UART/USART
Peripherals	DMA, PWM, WDT
Number of I/O	70
Program Memory Size	512KB (512K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	96K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 2x16b; D/A 1x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/nxp-semiconductors/mkv31f512vll12p">https://www.e-xfl.com/product-detail/nxp-semiconductors/mkv31f512vll12p</a>

**Table 5. Power consumption operating behaviors (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	@ 1.8V @ 3.0V	— —	35.5 35.6	36.83 36.93	mA mA	5
I <sub>DD_RUN</sub>	Run mode current in Compute operation — CoreMark benchmark code executing from flash @ 1.8V @ 3.0V	— —	17.5 17.5	18.83 18.83	mA mA	3, 4, 6
I <sub>DD_RUN</sub>	Run mode current in Compute operation — code executing from flash @ 1.8V @ 3.0V	— —	15.10 15.10	17.10 17.33	mA mA	6
I <sub>DD_RUN</sub>	Run mode current — all peripheral clocks disabled, code executing from flash @ 1.8V @ 3.0V	— —	16.6 16.8	17.93 18.13	mA mA	7
I <sub>DD_RUN</sub>	Run mode current — all peripheral clocks enabled, code executing from flash @ 1.8V @ 3.0V • @ 25°C • @ 70°C • @ 85°C • @ 105°C	— — — — —	22.8 22.9 23.1 23.5 23.8	24.13 24.23 24.43 24.83 25.13	mA mA mA mA mA	8
I <sub>DD_RUN</sub>	Run mode current — Compute operation, code executing from flash @ 1.8V @ 3.0V • @ 25°C • @ 70°C • @ 85°C • @ 105°C	— — — — —	15.1 15.1 15.4 15.6 16.0	16.43 16.43 16.73 16.93 17.33	mA mA mA mA mA	9
I <sub>DD_WAIT</sub>	Wait mode high frequency current at 3.0 V — all peripheral clocks disabled	—	9.3	10.63	mA	7
I <sub>DD_WAIT</sub>	Wait mode reduced frequency current at 3.0 V — all peripheral clocks disabled	—	5.4	6.73	mA	10
I <sub>DD_VLPR</sub>	Very-low-power run mode current in Compute operation — CoreMark benchmark code executing from flash @ 1.8V @ 3.0V	— —	0.88 0.89	1.02 1.03	mA mA	3, 4, 11

Table continues on the next page...

**Table 5. Power consumption operating behaviors (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I <sub>DD_VLLS1</sub>	Very low-leakage stop mode 1 current at 3.0 V @ -40°C to 25°C	—	0.73	1.42	μA	
	@ 70°C	—	1.8	3.90	μA	
	@ 85°C	—	3.0	5.25	μA	
	@ 105°C	—	5.9	10.80	μA	
I <sub>DD_VLLS0</sub>	Very low-leakage stop mode 0 current at 3.0 V with POR detect circuit enabled	—	0.43	0.55	μA	
	@ -40°C to 25°C	—	1.4	2.45	μA	
	@ 70°C	—	2.6	4.00	μA	
	@ 85°C	—	5.4	9.30	μA	
I <sub>DD_VLLS0</sub>	Very low-leakage stop mode 0 current at 3.0 V with POR detect circuit disabled	—	0.14	0.24	μA	
	@ -40°C to 25°C	—	1.1	2.15	μA	
	@ 70°C	—	2.3	3.85	μA	
	@ 85°C	—	5.1	9.00	μA	

- The analog supply current is the sum of the active or disabled current for each of the analog modules on the device. See each module's specification for its supply current.
- 120MHz core and system clock, 60MHz bus clock, 24MHz FlexBus clock, and 24MHz flash clock. MCG configured for PEE mode. All peripheral clocks disabled.
- Cache on and prefetch on, low compiler optimization.
- Coremark benchmark compiled using IAR 7.2 with optimization level low.
- 120MHz core and system clock, 60MHz bus clock, 24MHz FlexBus clock, and 24MHz flash clock. MCG configured for PEE mode. All peripheral clocks enabled.
- 80 MHz core and system clock, 40 MHz bus clock, and 26.67 MHz flash clock. MCG configured for PEE mode. Compute operation.
- 80MHz core and system clock, 40MHz bus clock, 20MHz FlexBus clock, and 26.67MHz flash clock. MCG configured for FEI mode. All peripheral clocks disabled.
- 80MHz core and system clock, 40MHz bus clock, 20MHz FlexBus clock, and 26.67MHz flash clock. MCG configured for FEI mode. All peripheral clocks enabled.
- 80MHz core and system clock, 40MHz bus clock, and 26.67MHz flash clock. MCG configured for FEI mode. Compute operation.
- 25MHz core and system clock, 25MHz bus clock, and 25MHz FlexBus and flash clock. MCG configured for FEI mode.
- 4 MHz core, system, FlexBus, and bus clock and 1MHz flash clock. MCG configured for BLPE mode. Compute operation. Code executing from flash.
- 4 MHz core, system, FlexBus, and bus clock and 1MHz flash clock. MCG configured for BLPE mode. All peripheral clocks disabled. Code executing from flash.
- 4 MHz core, system, FlexBus, and bus clock and 1MHz flash clock. MCG configured for BLPE mode. All peripheral clocks enabled but peripherals are not in active operation. Code executing from flash.
- 4 MHz core, system, FlexBus, and bus clock and 1MHz flash clock. MCG configured for BLPE mode. All peripheral clocks disabled.

### 2.2.5.1 Diagram: Typical IDD\_RUN operating behavior

The following data was measured under these conditions:

- MCG in FBE mode for 50 MHz and lower frequencies. MCG in FEE mode at frequencies between 50 MHz and 100MHz. MCG in PEE mode at frequencies greater than 100 MHz.
- No GPIOs toggled
- Code execution from flash with cache enabled
- For the ALLOFF curve, all peripheral clocks are disabled except FTFA

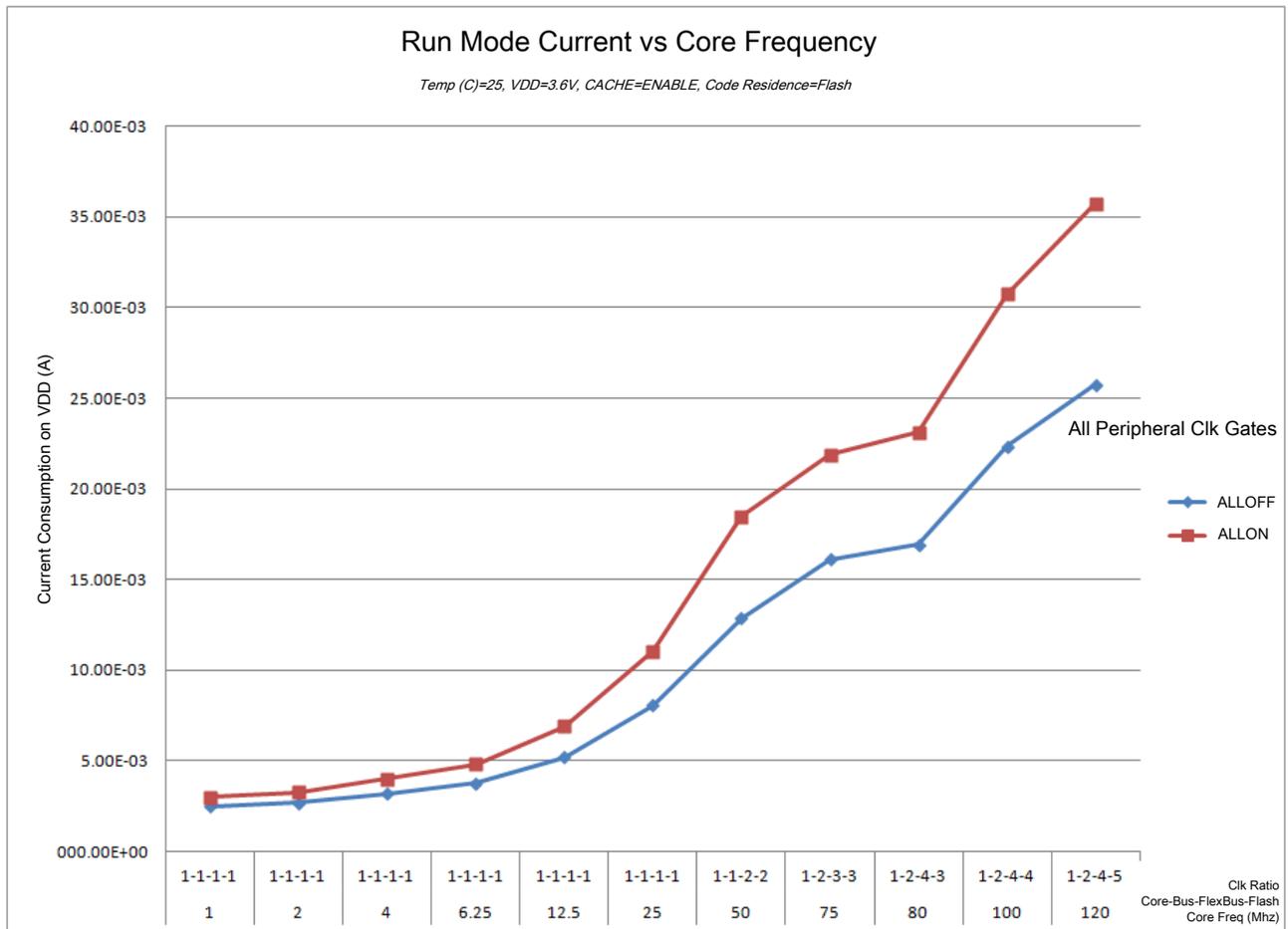


Figure 3. Run mode supply current vs. core frequency

### 3 Peripheral operating requirements and behaviors

#### 3.1 Core modules

##### 3.1.1 SWD electricals

Table 12. SWD full voltage range electricals

Symbol	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
S1	SWD_CLK frequency of operation <ul style="list-style-type: none"> <li>Serial wire debug</li> </ul>	0	33	MHz
S2	SWD_CLK cycle period	1/S1	—	ns
S3	SWD_CLK clock pulse width <ul style="list-style-type: none"> <li>Serial wire debug</li> </ul>	15	—	ns
S4	SWD_CLK rise and fall times	—	3	ns
S9	SWD_DIO input data setup time to SWD_CLK rise	8	—	ns
S10	SWD_DIO input data hold time after SWD_CLK rise	1.4	—	ns
S11	SWD_CLK high to SWD_DIO data valid	—	25	ns
S12	SWD_CLK high to SWD_DIO high-Z	5	—	ns

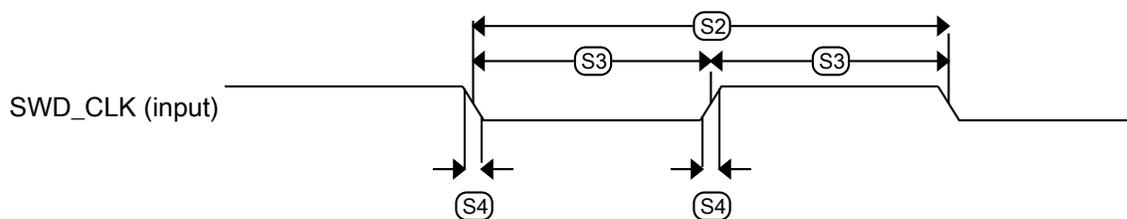


Figure 5. Serial wire clock input timing

Table 15. MCG specifications (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes	
$f_{loc\_low}$	Loss of external clock minimum frequency — RANGE = 00	$(3/5) \times f_{ints\_t}$	—	—	kHz		
$f_{loc\_high}$	Loss of external clock minimum frequency — RANGE = 01, 10, or 11	$(16/5) \times f_{ints\_t}$	—	—	kHz		
FLL							
$f_{fill\_ref}$	FLL reference frequency range	31.25	—	39.0625	kHz		
$f_{dco}$	DCO output frequency range	Low range (DRS=00) $640 \times f_{fill\_ref}$	20	20.97	25	MHz	3, 4
		Mid range (DRS=01) $1280 \times f_{fill\_ref}$	40	41.94	50	MHz	
		Mid-high range (DRS=10) $1920 \times f_{fill\_ref}$	60	62.91	75	MHz	
		High range (DRS=11) $2560 \times f_{fill\_ref}$	80	83.89	100	MHz	
$f_{dco\_t\_DMX3\_2}$	DCO output frequency	Low range (DRS=00) $732 \times f_{fill\_ref}$	—	23.99	—	MHz	5, 6
		Mid range (DRS=01) $1464 \times f_{fill\_ref}$	—	47.97	—	MHz	
		Mid-high range (DRS=10) $2197 \times f_{fill\_ref}$	—	71.99	—	MHz	
		High range (DRS=11) $2929 \times f_{fill\_ref}$	—	95.98	—	MHz	
$J_{cyc\_fill}$	FLL period jitter • $f_{VCO} = 48$ MHz • $f_{VCO} = 98$ MHz	—	— 180 150	—	ps		
$t_{fill\_acquire}$	FLL target frequency acquisition time	—	—	1	ms	7	
PLL							
$f_{vco}$	VCO operating frequency	48.0	—	120	MHz		
$I_{pll}$	PLL operating current • PLL @ 96 MHz ( $f_{osc\_hi\_1} = 8$ MHz, $f_{pll\_ref} = 2$ MHz, VDIV multiplier = 48)	—	1060	—	$\mu$ A	8	
$I_{pll}$	PLL operating current • PLL @ 48 MHz ( $f_{osc\_hi\_1} = 8$ MHz, $f_{pll\_ref} = 2$ MHz, VDIV multiplier = 24)	—	600	—	$\mu$ A	8	
$f_{pll\_ref}$	PLL reference frequency range	2.0	—	4.0	MHz		
$J_{cyc\_pll}$	PLL period jitter (RMS) • $f_{vco} = 48$ MHz • $f_{vco} = 100$ MHz	—	120	—	ps	9	
		—	75	—	ps		
$J_{acc\_pll}$	PLL accumulated jitter over 1 $\mu$ s (RMS)					9	

Table continues on the next page...

**Table 15. MCG specifications (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	<ul style="list-style-type: none"> <li><math>f_{VCO} = 48 \text{ MHz}</math></li> <li><math>f_{VCO} = 100 \text{ MHz}</math></li> </ul>	—	1350	—	ps	
$D_{lock}$	Lock entry frequency tolerance	$\pm 1.49$	—	$\pm 2.98$	%	
$D_{unl}$	Lock exit frequency tolerance	$\pm 4.47$	—	$\pm 5.97$	%	
$t_{pll\_lock}$	Lock detector detection time	—	—	$150 \times 10^{-6} + 1075(1/f_{pll\_ref})$	s	10

- This parameter is measured with the internal reference (slow clock) being used as a reference to the FLL (FEI clock mode).
- $2.0 \text{ V} \leq VDD \leq 3.6 \text{ V}$ .
- These typical values listed are with the slow internal reference clock (FEI) using factory trim and DMX32=0.
- The resulting system clock frequencies should not exceed their maximum specified values. The DCO frequency deviation ( $\Delta f_{dco\_t}$ ) over voltage and temperature should be considered.
- These typical values listed are with the slow internal reference clock (FEI) using factory trim and DMX32=1.
- The resulting clock frequency must not exceed the maximum specified clock frequency of the device.
- This specification applies to any time the FLL reference source or reference divider is changed, trim value is changed, DMX32 bit is changed, DRS bits are changed, or changing from FLL disabled (BLPE, BLPI) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
- Excludes any oscillator currents that are also consuming power while PLL is in operation.
- This specification was obtained using a Freescale developed PCB. PLL jitter is dependent on the noise characteristics of each PCB and results will vary.
- This specification applies to any time the PLL VCO divider or reference divider is changed, or changing from PLL disabled (BLPE, BLPI) to PLL enabled (PBE, PEE). If a crystal/resonator is being used as the reference, this specification assumes it is already running.

### 3.3.2 IRC48M specifications

**Table 16. IRC48M specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$V_{DD}$	Supply voltage	1.71	—	3.6	V	
$I_{DD48M}$	Supply current	—	400	500	$\mu\text{A}$	
$f_{irc48m}$	Internal reference frequency	—	48	—	MHz	
$\Delta f_{irc48m\_ol\_hv}$	Open loop total deviation of IRC48M frequency at high voltage ( $VDD=1.89\text{V}-3.6\text{V}$ ) over $0^\circ\text{C}$ to $70^\circ\text{C}$	—	$\pm 0.2$	$\pm 0.5$	$\%f_{irc48m}$	1
$\Delta f_{irc48m\_ol\_hv}$	Open loop total deviation of IRC48M frequency at high voltage ( $VDD=1.89\text{V}-3.6\text{V}$ ) over full temperature	—	$\pm 0.4$	$\pm 1.0$	$\%f_{irc48m}$	1
$\Delta f_{irc48m\_ol\_lv}$	Open loop total deviation of IRC48M frequency at low voltage ( $VDD=1.71\text{V}-1.89\text{V}$ ) over full temperature	—	$\pm 0.5$	$\pm 1.5$	$\%f_{irc48m}$	1
$J_{cyc\_irc48m}$	Period Jitter (RMS)	—	35	150	ps	
$t_{irc48mst}$	Startup time	—	2	3	$\mu\text{s}$	2

- The maximum value represents characterized results equivalent to the mean plus or minus three times the standard deviation (mean  $\pm 3$  sigma).

**Table 18. Oscillator frequency specifications (continued)**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	Crystal startup time — 8 MHz high-frequency (MCG_C2[RANGE]=01), low-power mode (HGO=0)	—	0.6	—	ms	
	Crystal startup time — 8 MHz high-frequency (MCG_C2[RANGE]=01), high-gain mode (HGO=1)	—	1	—	ms	

1. Other frequency limits may apply when external clock is being used as a reference for the FLL or PLL.
2. When transitioning from FEI or FBI to FBE mode, restrict the frequency of the input clock so that, when it is divided by FRDIV, it remains within the limits of the DCO input clock frequency.
3. Proper PC board layout procedures must be followed to achieve specifications.
4. Crystal startup time is defined as the time between the oscillator being enabled and the OSCINIT bit in the MCG\_S register being set.

## 3.4 Memories and memory interfaces

### 3.4.1 Flash electrical specifications

This section describes the electrical characteristics of the flash memory module.

#### 3.4.1.1 Flash timing specifications — program and erase

The following specifications represent the amount of time the internal charge pumps are active and do not include command overhead.

**Table 19. NVM program/erase timing specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$t_{hvpgm4}$	Longword Program high-voltage time	—	7.5	18	$\mu$ s	—
$t_{hversscr}$	Sector Erase high-voltage time	—	13	113	ms	1
$t_{hversblk256k}$	Erase Block high-voltage time for 256 KB	—	104	904	ms	1

1. Maximum time based on expectations at cycling end-of-life.

#### 3.4.1.2 Flash timing specifications — commands

**Table 20. Flash command timing specifications**

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	Read 1s Block execution time					1

*Table continues on the next page...*

### 3.4.3 Flexbus switching specifications

All processor bus timings are synchronous; input setup/hold and output delay are given in respect to the rising edge of a reference clock, FB\_CLK. The FB\_CLK frequency may be the same as the internal system bus frequency or an integer divider of that frequency.

The following timing numbers indicate when data is latched or driven onto the external bus, relative to the Flexbus output clock (FB\_CLK). All other timing relationships can be derived from these values.

**Table 24. Flexbus limited voltage range switching specifications**

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	2.7	3.6	V	
	Frequency of operation	—	30	MHz	
FB1	Clock period	33.3	—	ns	
FB2	Address, data, and control output valid	—	15	ns	
FB3	Address, data, and control output hold	0.5	—	ns	1
FB4	Data and $\overline{\text{FB\_TA}}$ input setup	14.5	—	ns	
FB5	Data and $\overline{\text{FB\_TA}}$ input hold	0.5	—	ns	2

1. Specification is valid for all FB\_AD[31:0],  $\overline{\text{FB\_BE/BWEn}}$ ,  $\overline{\text{FB\_CSn}}$ ,  $\overline{\text{FB\_OE}}$ , FB\_R/W, FB\_TBST, FB\_TSIZ[1:0], FB\_ALE, and FB\_TS.
2. Specification is valid for all FB\_AD[31:0] and  $\overline{\text{FB\_TA}}$ .

**Table 25. Flexbus full voltage range switching specifications**

Num	Description	Min.	Max.	Unit	Notes
	Operating voltage	1.71	3.6	V	
	Frequency of operation	—	30	MHz	
FB1	Clock period	33.3	—	ns	
FB2	Address, data, and control output valid	—	21.5	ns	
FB3	Address, data, and control output hold	-1.0	—	ns	1
FB4	Data and $\overline{\text{FB\_TA}}$ input setup	20.0	—	ns	
FB5	Data and $\overline{\text{FB\_TA}}$ input hold	0.5	—	ns	2

1. Specification is valid for all FB\_AD[31:0],  $\overline{\text{FB\_BE/BWEn}}$ ,  $\overline{\text{FB\_CSn}}$ ,  $\overline{\text{FB\_OE}}$ , FB\_R/W, FB\_TBST, FB\_TSIZ[1:0], FB\_ALE, and FB\_TS.
2. Specification is valid for all FB\_AD[31:0] and  $\overline{\text{FB\_TA}}$ .

### 3.6.1 ADC electrical specifications

The 16-bit accuracy specifications listed in [Table 26](#) and [Table 27](#) are achievable on the differential pins ADCx\_DPx, ADCx\_DMx.

All other ADC channels meet the 13-bit differential/12-bit single-ended accuracy specifications.

#### 3.6.1.1 16-bit ADC operating conditions

**Table 26. 16-bit ADC operating conditions**

Symbol	Description	Conditions	Min.	Typ. <sup>1</sup>	Max.	Unit	Notes
V <sub>DDA</sub>	Supply voltage	Absolute	1.71	—	3.6	V	
ΔV <sub>DDA</sub>	Supply voltage	Delta to V <sub>DD</sub> (V <sub>DD</sub> – V <sub>DDA</sub> )	-100	0	+100	mV	2
ΔV <sub>SSA</sub>	Ground voltage	Delta to V <sub>SS</sub> (V <sub>SS</sub> – V <sub>SSA</sub> )	-100	0	+100	mV	2
V <sub>REFH</sub>	ADC reference voltage high		1.13	V <sub>DDA</sub>	V <sub>DDA</sub>	V	
V <sub>REFL</sub>	ADC reference voltage low		V <sub>SSA</sub>	V <sub>SSA</sub>	V <sub>SSA</sub>	V	
V <sub>ADIN</sub>	Input voltage	<ul style="list-style-type: none"> <li>16-bit differential mode</li> <li>All other modes</li> </ul>	V <sub>REFL</sub> V <sub>REFL</sub>	— —	31/32 * V <sub>REFH</sub> V <sub>REFH</sub>	V	
C <sub>ADIN</sub>	Input capacitance	<ul style="list-style-type: none"> <li>16-bit mode</li> <li>8-bit / 10-bit / 12-bit modes</li> </ul>	— —	8 4	10 5	pF	
R <sub>ADIN</sub>	Input series resistance		—	2	5	kΩ	
R <sub>AS</sub>	Analog source resistance (external)	13-bit / 12-bit modes f <sub>ADCK</sub> < 4 MHz	—	—	5	kΩ	3
f <sub>ADCK</sub>	ADC conversion clock frequency	≤ 13-bit mode	1.0	—	24.0	MHz	4
f <sub>ADCK</sub>	ADC conversion clock frequency	16-bit mode	2.0	—	12.0	MHz	4
C <sub>rate</sub>	ADC conversion rate	≤ 13-bit modes No ADC hardware averaging Continuous conversions enabled, subsequent conversion time	20	—	1200	Ksps	5
C <sub>rate</sub>	ADC conversion rate	16-bit mode No ADC hardware averaging	37	—	461	Ksps	5

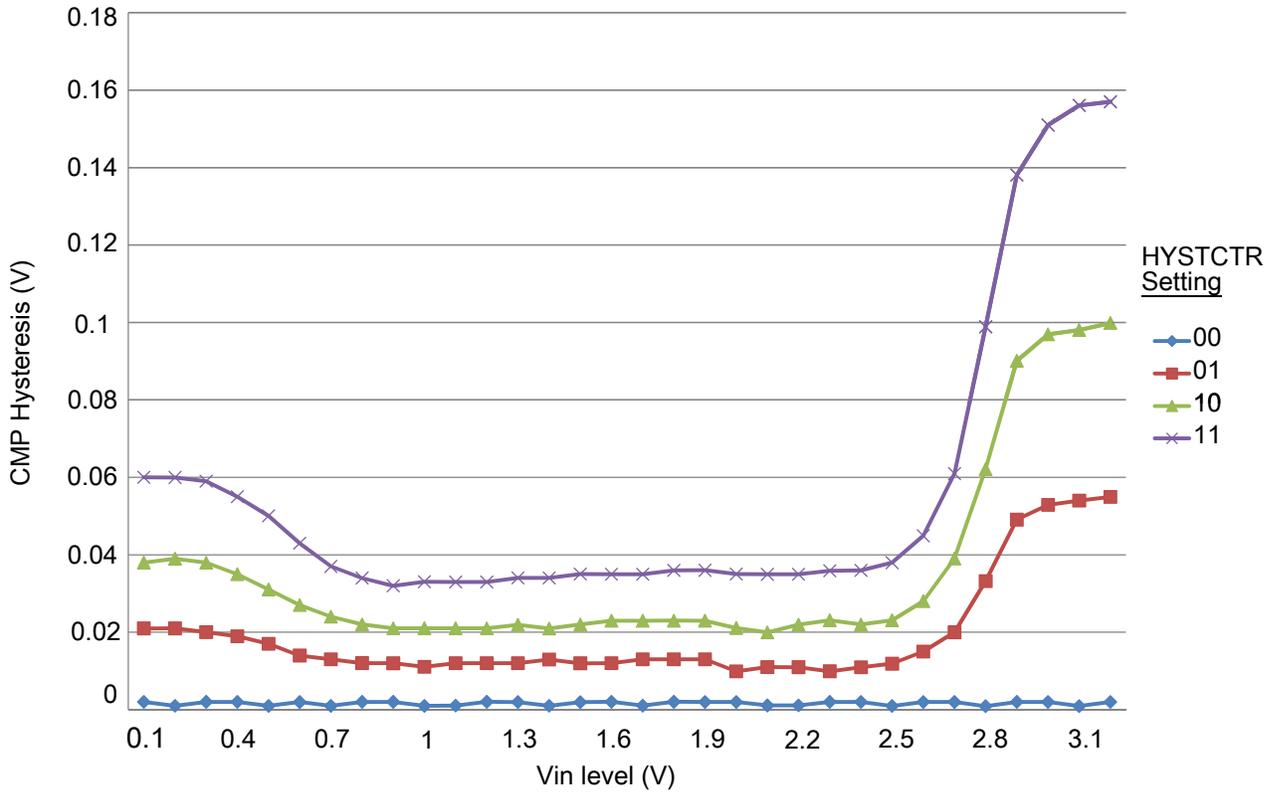


Figure 18. Typical hysteresis vs. Vin level (VDD = 3.3 V, PMODE = 1)

### 3.6.3 12-bit DAC electrical characteristics

#### 3.6.3.1 12-bit DAC operating requirements

Table 29. 12-bit DAC operating requirements

Symbol	Description	Min.	Max.	Unit	Notes
$V_{DDA}$	Supply voltage	1.71	3.6	V	
$V_{DACR}$	Reference voltage	1.13	3.6	V	1
$C_L$	Output load capacitance	—	100	pF	2
$I_L$	Output load current	—	1	mA	

1. The DAC reference can be selected to be  $V_{DDA}$  or  $V_{REFH}$ .
2. A small load capacitance (47 pF) can improve the bandwidth performance of the DAC.

### 3.6.3.2 12-bit DAC operating behaviors

Table 30. 12-bit DAC operating behaviors

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
$I_{DDA\_DACLP}$	Supply current — low-power mode	—	—	330	$\mu\text{A}$	
$I_{DDA\_DACHP}$	Supply current — high-speed mode	—	—	1200	$\mu\text{A}$	
$t_{DACLP}$	Full-scale settling time (0x080 to 0xF7F) — low-power mode	—	100	200	$\mu\text{s}$	1
$t_{DACHP}$	Full-scale settling time (0x080 to 0xF7F) — high-power mode	—	15	30	$\mu\text{s}$	1
$t_{CCDACLP}$	Code-to-code settling time (0xBF8 to 0xC08) — low-power mode and high-speed mode	—	0.7	1	$\mu\text{s}$	1
$V_{dacoutl}$	DAC output voltage range low — high-speed mode, no load, DAC set to 0x000	—	—	100	mV	
$V_{dacouth}$	DAC output voltage range high — high-speed mode, no load, DAC set to 0xFFFF	$V_{DACR} - 100$	—	$V_{DACR}$	mV	
INL	Integral non-linearity error — high speed mode	—	—	$\pm 8$	LSB	2
DNL	Differential non-linearity error — $V_{DACR} > 2\text{ V}$	—	—	$\pm 1$	LSB	3
DNL	Differential non-linearity error — $V_{DACR} = V_{REF\_OUT}$	—	—	$\pm 1$	LSB	4
$V_{OFFSET}$	Offset error	—	$\pm 0.4$	$\pm 0.8$	%FSR	5
$E_G$	Gain error	—	$\pm 0.1$	$\pm 0.6$	%FSR	5
PSRR	Power supply rejection ratio, $V_{DDA} \geq 2.4\text{ V}$	60	—	90	dB	
$T_{CO}$	Temperature coefficient offset voltage	—	3.7	—	$\mu\text{V}/\text{C}$	6
$T_{GE}$	Temperature coefficient gain error	—	0.000421	—	%FSR/C	
$R_{op}$	Output resistance (load = 3 k $\Omega$ )	—	—	250	$\Omega$	
SR	Slew rate -80h → F7Fh → 80h <ul style="list-style-type: none"> <li>High power (<math>SP_{HP}</math>)</li> <li>Low power (<math>SP_{LP}</math>)</li> </ul>	1.2 0.05	1.7 0.12	— —	V/ $\mu\text{s}$	
BW	3dB bandwidth <ul style="list-style-type: none"> <li>High power (<math>SP_{HP}</math>)</li> <li>Low power (<math>SP_{LP}</math>)</li> </ul>	550 40	— —	— —	kHz	

- Settling within  $\pm 1$  LSB
- The INL is measured for 0 + 100 mV to  $V_{DACR} - 100$  mV
- The DNL is measured for 0 + 100 mV to  $V_{DACR} - 100$  mV
- The DNL is measured for 0 + 100 mV to  $V_{DACR} - 100$  mV with  $V_{DDA} > 2.4\text{ V}$
- Calculated by a best fit curve from  $V_{SS} + 100$  mV to  $V_{DACR} - 100$  mV
- $V_{DDA} = 3.0\text{ V}$ , reference select set for  $V_{DDA}$  (DACx\_CO:DACRFS = 1), high power mode (DACx\_CO:LPEN = 0), DAC set to 0x800, temperature range is across the full range of the device

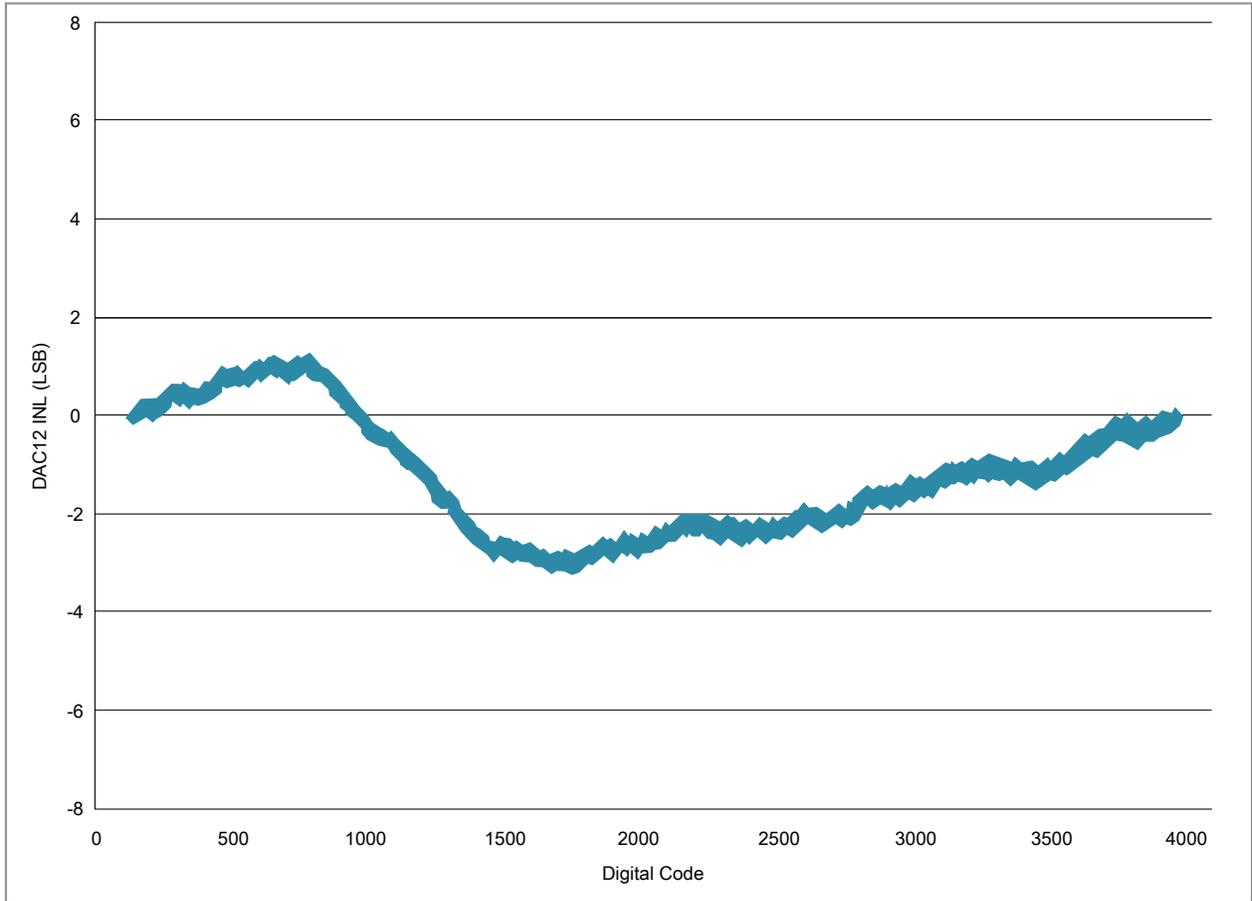


Figure 19. Typical INL error vs. digital code

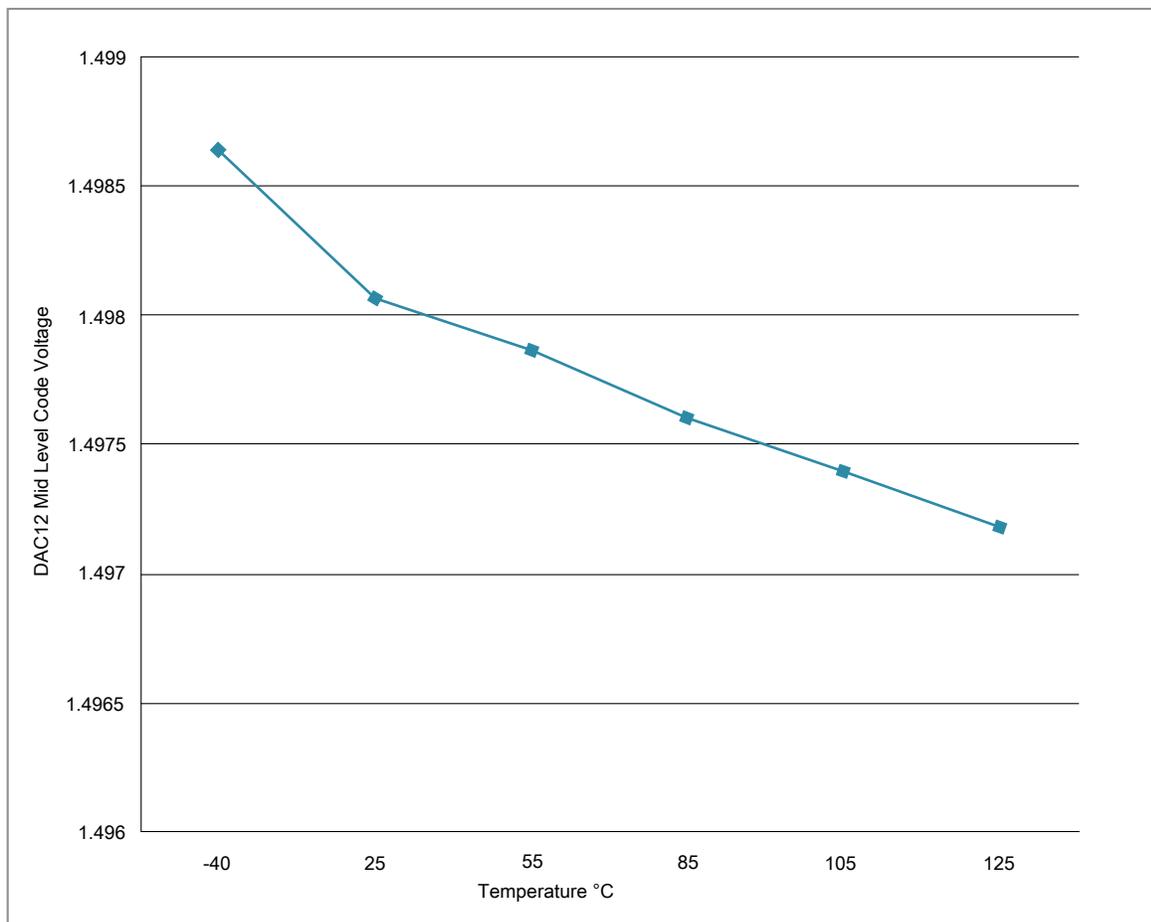


Figure 20. Offset at half scale vs. temperature

### 3.6.4 Voltage reference electrical specifications

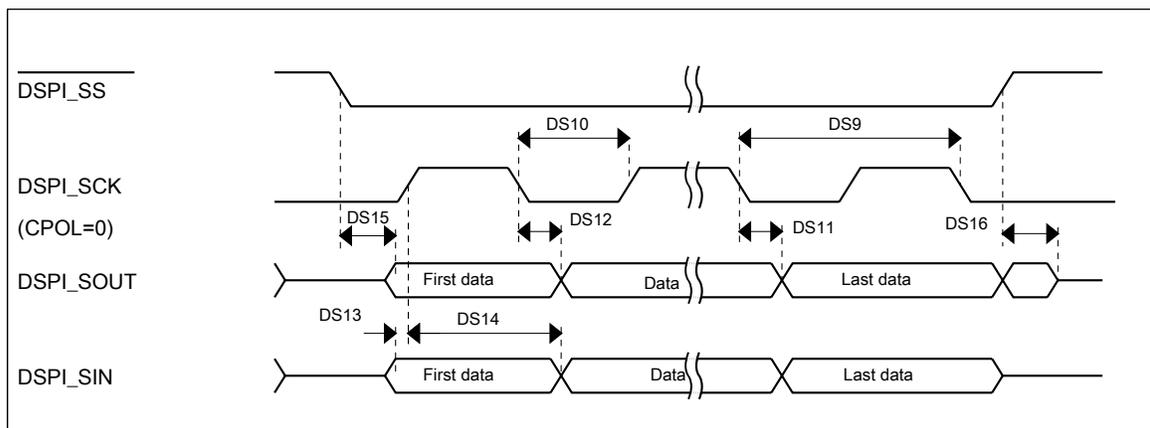
Table 31. VREF full-range operating requirements

Symbol	Description	Min.	Max.	Unit	Notes
$V_{DDA}$	Supply voltage	1.71	3.6	V	
$T_A$	Temperature	Operating temperature range of the device		°C	
$C_L$	Output load capacitance	100		nF	1, 2

1.  $C_L$  must be connected to VREF\_OUT if the VREF\_OUT functionality is being used for either an internal or external reference.
2. The load capacitance should not exceed +/-25% of the nominal specified  $C_L$  value over the operating temperature range of the device.

**Table 38. Slave mode DSPI timing (full voltage range)**

Num	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
	Frequency of operation	—	7.5	MHz
DS9	DSPI_SCK input cycle time	$8 \times t_{\text{BUS}}$	—	ns
DS10	DSPI_SCK input high/low time	$(t_{\text{SCK}}/2) - 4$	$(t_{\text{SCK}}/2) + 4$	ns
DS11	DSPI_SCK to DSPI_SOUT valid	—	29.5	ns
DS12	DSPI_SCK to DSPI_SOUT invalid	0	—	ns
DS13	DSPI_SIN to DSPI_SCK input setup	3.2	—	ns
DS14	DSPI_SCK to DSPI_SIN input hold	7	—	ns
DS15	$\overline{\text{DSPI\_SS}}$ active to DSPI_SOUT driven	—	25	ns
DS16	$\overline{\text{DSPI\_SS}}$ inactive to DSPI_SOUT not driven	—	25	ns

**Figure 24. DSPI classic SPI timing — slave mode**

### 3.8.3 Inter-Integrated Circuit Interface (I<sup>2</sup>C) timing

**Table 39. I<sup>2</sup>C timing**

Characteristic	Symbol	Standard Mode		Fast Mode		Unit
		Minimum	Maximum	Minimum	Maximum	
SCL Clock Frequency	$f_{\text{SCL}}$	0	100	0	400 <sup>1</sup>	kHz
Hold time (repeated) START condition. After this period, the first clock pulse is generated.	$t_{\text{HD}}$ ; STA	4	—	0.6	—	$\mu\text{s}$
LOW period of the SCL clock	$t_{\text{LOW}}$	4.7	—	1.25	—	$\mu\text{s}$
HIGH period of the SCL clock	$t_{\text{HIGH}}$	4	—	0.6	—	$\mu\text{s}$
Set-up time for a repeated START condition	$t_{\text{SU}}$ ; STA	4.7	—	0.6	—	$\mu\text{s}$

Table continues on the next page...

100 LQFP	64 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	EzPort
17	—	ADC1_DM1/ ADC0_DM2	ADC1_DM1/ ADC0_DM2	ADC1_DM1/ ADC0_DM2								
18	9	ADC0_DP0/ ADC1_DP3	ADC0_DP0/ ADC1_DP3	ADC0_DP0/ ADC1_DP3								
19	10	ADC0_DM0/ ADC1_DM3	ADC0_DM0/ ADC1_DM3	ADC0_DM0/ ADC1_DM3								
20	11	ADC1_DP0/ ADC0_DP3	ADC1_DP0/ ADC0_DP3	ADC1_DP0/ ADC0_DP3								
21	12	ADC1_DM0/ ADC0_DM3	ADC1_DM0/ ADC0_DM3	ADC1_DM0/ ADC0_DM3								
22	13	VDDA	VDDA	VDDA								
23	14	VREFH	VREFH	VREFH								
24	15	VREFL	VREFL	VREFL								
25	16	VSSA	VSSA	VSSA								
26	17	VREF_OUT/ CMP1_IN5/ CMP0_IN5/ ADC1_SE18	VREF_OUT/ CMP1_IN5/ CMP0_IN5/ ADC1_SE18	VREF_OUT/ CMP1_IN5/ CMP0_IN5/ ADC1_SE18								
27	18	DAC0_OUT/ CMP1_IN3/ ADC0_SE23	DAC0_OUT/ CMP1_IN3/ ADC0_SE23	DAC0_OUT/ CMP1_IN3/ ADC0_SE23								
28	19	DAC1_OUT/ CMP0_IN4/ ADC1_SE23	DAC1_OUT/ CMP0_IN4/ ADC1_SE23	DAC1_OUT/ CMP0_IN4/ ADC1_SE23								
29	—	VSS	VSS	VSS								
30	—	VDD	VDD	VDD								
31	20	PTE24	ADC0_SE17	ADC0_SE17	PTE24		FTM0_CH0		I2C0_SCL	EWM_OUT_ b		
32	21	PTE25	ADC0_SE18	ADC0_SE18	PTE25		FTM0_CH1		I2C0_SDA	EWM_IN		
33	—	PTE26/ CLKOUT32K	DISABLED		PTE26/ CLKOUT32K							
34	22	PTA0	JTAG_TCLK/ SWD_CLK/ EZP_CLK		PTA0	UART0_ CTS_b	FTM0_CH5		EWM_IN		JTAG_TCLK/ SWD_CLK	EZP_CLK
35	23	PTA1	JTAG_TDI/ EZP_DI		PTA1	UART0_RX	FTM0_CH6	CMP0_OUT	FTM2_QD_ PHA	FTM1_CH1	JTAG_TDI	EZP_DI
36	24	PTA2	JTAG_TDO/ TRACE_ SWO/ EZP_DO		PTA2	UART0_TX	FTM0_CH7	CMP1_OUT	FTM2_QD_ PHB	FTM1_CH0	JTAG_TDO/ TRACE_ SWO	EZP_DO
37	25	PTA3	JTAG_TMS/ SWD_DIO		PTA3	UART0_ RTS_b	FTM0_CH0	FTM2_FLT0	EWM_OUT_ b		JTAG_TMS/ SWD_DIO	
38	26	PTA4/ LLWU_P3	NMI_b/ EZP_CS_b		PTA4/ LLWU_P3		FTM0_CH1		FTM0_FLT3		NMI_b	EZP_CS_b
39	27	PTA5	DISABLED		PTA5		FTM0_CH2				JTAG_ TRST_b	

## Pinout

100 LQFP	64 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	EzPort
40	—	VDD	VDD	VDD								
41	—	VSS	VSS	VSS								
42	28	PTA12	DISABLED		PTA12		FTM1_CH0				FTM1_QD_PHA	
43	29	PTA13/LLWU_P4	DISABLED		PTA13/LLWU_P4		FTM1_CH1				FTM1_QD_PHB	
44	—	PTA14	DISABLED		PTA14	SPI0_PCS0	UART0_TX					
45	—	PTA15	DISABLED		PTA15	SPI0_SCK	UART0_RX					
46	—	PTA16	DISABLED		PTA16	SPI0_SOUT	UART0_CTS_b					
47	—	PTA17	ADC1_SE17	ADC1_SE17	PTA17	SPI0_SIN	UART0_RTS_b					
48	30	VDD	VDD	VDD								
49	31	VSS	VSS	VSS								
50	32	PTA18	EXTAL0	EXTAL0	PTA18		FTM0_FLT2	FTM_CLKIN0				
51	33	PTA19	XTAL0	XTAL0	PTA19	FTM0_FLT0	FTM1_FLT0	FTM_CLKIN1		LPTMR0_ALT1		
52	34	RESET_b	RESET_b	RESET_b								
53	35	PTB0/LLWU_P5	ADC0_SE8/ADC1_SE8	ADC0_SE8/ADC1_SE8	PTB0/LLWU_P5	I2C0_SCL	FTM1_CH0			FTM1_QD_PHA	UART0_RX	
54	36	PTB1	ADC0_SE9/ADC1_SE9	ADC0_SE9/ADC1_SE9	PTB1	I2C0_SDA	FTM1_CH1	FTM0_FLT2	EWM_IN	FTM1_QD_PHB	UART0_TX	
55	37	PTB2	ADC0_SE12	ADC0_SE12	PTB2	I2C0_SCL	UART0_RTS_b	FTM0_FLT1		FTM0_FLT3		
56	38	PTB3	ADC0_SE13	ADC0_SE13	PTB3	I2C0_SDA	UART0_CTS_b			FTM0_FLT0		
57	—	PTB9	DISABLED		PTB9	SPI1_PCS1	LPUART0_CTS_b		FB_AD20			
58	—	PTB10	ADC1_SE14	ADC1_SE14	PTB10	SPI1_PCS0	LPUART0_RX		FB_AD19	FTM0_FLT1		
59	—	PTB11	ADC1_SE15	ADC1_SE15	PTB11	SPI1_SCK	LPUART0_TX		FB_AD18	FTM0_FLT2		
60	—	VSS	VSS	VSS								
61	—	VDD	VDD	VDD								
62	39	PTB16	DISABLED		PTB16	SPI1_SOUT	UART0_RX	FTM_CLKIN0	FB_AD17	EWM_IN		
63	40	PTB17	DISABLED		PTB17	SPI1_SIN	UART0_TX	FTM_CLKIN1	FB_AD16	EWM_OUT_b		
64	41	PTB18	DISABLED		PTB18		FTM2_CH0		FB_AD15	FTM2_QD_PHA		
65	42	PTB19	DISABLED		PTB19		FTM2_CH1		FB_OE_b	FTM2_QD_PHB		
66	—	PTB20	DISABLED		PTB20				FB_AD31	CMP0_OUT		
67	—	PTB21	DISABLED		PTB21				FB_AD30	CMP1_OUT		
68	—	PTB22	DISABLED		PTB22				FB_AD29			

## Pinout

100 LQFP	64 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7	EzPort
93	57	PTD0/ LLWU_P12	DISABLED		PTD0/ LLWU_P12	SPI0_PCS0	UART2_ RTS_b	FTM3_CH0	FB_ALE/ FB_CS1_b/ FB_TS_b	LPUART0_ RTS_b		
94	58	PTD1	ADC0_SE5b	ADC0_SE5b	PTD1	SPI0_SCK	UART2_ CTS_b	FTM3_CH1	FB_CS0_b	LPUART0_ CTS_b		
95	59	PTD2/ LLWU_P13	DISABLED		PTD2/ LLWU_P13	SPI0_SOUT	UART2_RX	FTM3_CH2	FB_AD4	LPUART0_ RX	I2C0_SCL	
96	60	PTD3	DISABLED		PTD3	SPI0_SIN	UART2_TX	FTM3_CH3	FB_AD3	LPUART0_ TX	I2C0_SDA	
97	61	PTD4/ LLWU_P14	DISABLED		PTD4/ LLWU_P14	SPI0_PCS1	UART0_ RTS_b	FTM0_CH4	FB_AD2	EWM_IN	SPI1_PCS0	
98	62	PTD5	ADC0_SE6b	ADC0_SE6b	PTD5	SPI0_PCS2	UART0_ CTS_b	FTM0_CH5	FB_AD1	EWM_OUT_ b	SPI1_SCK	
99	63	PTD6/ LLWU_P15	ADC0_SE7b	ADC0_SE7b	PTD6/ LLWU_P15	SPI0_PCS3	UART0_RX	FTM0_CH6	FB_AD0	FTM0_FLT0	SPI1_SOUT	
100	64	PTD7	DISABLED		PTD7		UART0_TX	FTM0_CH7		FTM0_FLT1	SPI1_SIN	

## 5.2 Recommended connection for unused analog and digital pins

The following table shows the recommended connections for analog interface pins if those analog interfaces are not used in the customer's application.

**Table 41. Recommended connection for unused analog interfaces**

Pin Type		Short recommendation	Detailed recommendation
Analog/non GPIO	PGAx/ADCx	Float	Analog input - Float
Analog/non GPIO	ADCx/CMPx	Float	Analog input - Float
Analog/non GPIO	VREF_OUT	Float	Analog output - Float
Analog/non GPIO	DACx_OUT	Float	Analog output - Float
Analog/non GPIO	RTC_WAKEUP_B	Float	Analog output - Float
Analog/non GPIO	XTAL32	Float	Analog output - Float
Analog/non GPIO	EXTAL32	Float	Analog input - Float
GPIO/Analog	PTA18/EXTAL0	Float	Analog input - Float
GPIO/Analog	PTA19/XTAL0	Float	Analog output - Float
GPIO/Analog	PTx/ADCx	Float	Float (default is analog input)
GPIO/Analog	PTx/CMPx	Float	Float (default is analog input)
GPIO/Digital	PTA0/JTAG_TCLK	Float	Float (default is JTAG with pulldown)
GPIO/Digital	PTA1/JTAG_TDI	Float	Float (default is JTAG with pullup)

*Table continues on the next page...*

## 6.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

## 6.2 Format

Part numbers for this device have the following format:

Q KV## A FFF R T PP CC S N

## 6.3 Fields

This table lists the possible values for each field in the part number (not all combinations are valid):

Field	Description	Values
Q	Qualification status	<ul style="list-style-type: none"> <li>M = Fully qualified, general market flow</li> <li>P = Prequalification</li> </ul>
KV##	Kinetis V Series	<ul style="list-style-type: none"> <li>KV3x: Cortex-M4 based MCU</li> </ul>
A	Key attribute	<ul style="list-style-type: none"> <li>D = Cortex-M4 w/ DSP</li> <li>F = Cortex-M4 w/ DSP and FPU</li> </ul>
FFF	Program flash memory size	<ul style="list-style-type: none"> <li>64 = 64 KB</li> <li>128 = 128 KB</li> <li>256 = 256 KB</li> <li>512 = 512 KB</li> </ul>
R	Silicon revision	<ul style="list-style-type: none"> <li>(Blank) = Main</li> <li>A = Revision after main</li> </ul>
T	Temperature range (°C)	<ul style="list-style-type: none"> <li>V = -40 to 105</li> <li>C = -40 to 85</li> </ul>
PP	Package identifier	<ul style="list-style-type: none"> <li>FM = 32 QFN (5 mm x 5 mm)</li> <li>LF = 48 LQFP (7 mm x 7 mm)</li> <li>LH = 64 LQFP (10 mm x 10 mm)</li> <li>LL = 100 LQFP (14 mm x 14 mm)</li> <li>MC = 121 XFBGA (8 mm x 8 mm)</li> <li>DC = 121 XFBGA (8 mm x 8 mm x 0.5 mm)</li> </ul>
CC	Maximum CPU frequency (MHz)	<ul style="list-style-type: none"> <li>10 = 100 MHz</li> <li>12 = 120 MHz</li> </ul>
S	Software type	<ul style="list-style-type: none"> <li>P = KMS-PMSM and BLDC</li> <li>(Blank) = Not software enabled</li> </ul>
N	Packaging type	<ul style="list-style-type: none"> <li>R = Tape and reel</li> <li>(Blank) = Trays</li> </ul>

**Table 42. Revision History (continued)**

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> <li>Added Terminology and Guidelines section</li> <li>Updated IRC48M specifications table</li> </ul>
6	10/2015	<ul style="list-style-type: none"> <li>In "Power consumption operating behaviors" section, added "Low power mode peripheral adders—typical value" table</li> <li>In "Thermal operating requirements" table, in footnote, corrected "<math>T_J = T_A + \Theta_{JA}</math>" to "<math>T_J = T_A + R_{\Theta JA}</math>"</li> <li>Updated "IRC48M specifications" table</li> <li>Updated "NVM program/erase timing specifications" table; removed row for <math>t_{hversall}</math> and added row for <math>t_{hversblk256k}</math></li> <li>Updated "Flash command timing specifications" table; added rows for <math>t_{rd1blk256k}</math> and <math>t_{ersblk256k}</math></li> <li>In "Slave mode DSPI timing (limited voltage range)" table, added footnote regarding maximum frequency of operation</li> <li>Added new section, "Recommended connections for unused analog and digital pins"</li> </ul>
5	4/2015	<ul style="list-style-type: none"> <li>On page 1:                             <ul style="list-style-type: none"> <li>Under "Security and integrity modules" added "Hardware random-number generator"</li> <li>Under "Communication interfaces," updated I<sup>2</sup>C bullet to indicate support for up to 1 Mbps operation</li> <li>Under "Operating characteristics," specified that voltage range includes flash writes</li> </ul> </li> <li>In figure, "Functional block diagram," added "Random-number generator."</li> <li>In "Voltage and current operating requirements" table:                             <ul style="list-style-type: none"> <li>Removed content related to positive injection</li> <li>Updated footnote 1 to say that all analog and I/O pins are internally clamped to V<sub>SS</sub> only (not V<sub>SS</sub> and V<sub>DD</sub>)through ESD protection diodes.</li> </ul> </li> <li>In "Power consumption operating behaviors" table:                             <ul style="list-style-type: none"> <li>Added additional temperature data in power consumption table</li> <li>Added Max IDD values based on characterization results equivalent to mean + 3 sigma</li> </ul> </li> <li>Updated "EMC radiated emissions operating behaviors" table</li> <li>In "Thermal operating requirements" table, added the following footnote for ambient temperature: "Maximum T<sub>A</sub> can be exceeded only if the user ensures that T<sub>J</sub> does not exceed maximum T<sub>J</sub>. The simplest method to determine T<sub>J</sub> is: <math>T_J = T_A + \Theta_{JA} \times</math> chip power dissipation"</li> <li>Updated "IRC48M Specifications":                             <ul style="list-style-type: none"> <li>Updated maximum values for <math>\Delta_{firc48m\_lv}</math> and <math>\Delta_{firc48m\_hv}</math> (full temperature)</li> <li>Added specifications for <math>\Delta_{firc48m\_hv}</math> (-40°C to 85°C)</li> </ul> </li> <li>In "I<sup>2</sup>C timing" table,                             <ul style="list-style-type: none"> <li>Added the following footnote on maximum Fast mode value for SCL Clock Frequency: "The maximum SCL Clock Frequency in Fast mode with maximum bus loading can only be achieved when using the High drive pins across the full voltage range and when using the Normal drive pins and VDD ≥ 2.7 V."</li> <li>Updated minimum Fast mode value for LOW period of the SCL clock to 1.25 μ</li> </ul> </li> <li>Added "I<sup>2</sup>C 1 Mbps timing" table</li> <li>Removed Section 6, "Ordering parts."</li> <li>Specified that the figure, "KV31F 64 LQFP Pinout Diagram" is a top view</li> <li>Specified that the figure, "KV31F 100 LQFP Pinout Diagram" is a top view</li> </ul>
4	7/2014	<ul style="list-style-type: none"> <li>In "Power consumption operating behaviors table":</li> </ul>

*Table continues on the next page...*

**Table 42. Revision History (continued)**

Rev. No.	Date	Substantial Changes
		<ul style="list-style-type: none"> <li>• Updated existing typical power measurements</li> <li>• Added new typical power measurements for the following:               <ul style="list-style-type: none"> <li>• IDD_HSRUN (High Speed Run mode current executing CoreMark code)</li> <li>• IDD_RUNCO (Run mode current in Compute operation, executing CoreMark code)</li> <li>• IDD_RUN (Run mode current in Compute operation, executing while(1) loop)</li> <li>• IDD_VLPR (Very Low Power mode current executing CoreMark code)</li> <li>• IDD_VLPR (Very Low Power Run mode current in Compute operation, executing while(1) loop)</li> </ul> </li> </ul>
3	5/2014	<ul style="list-style-type: none"> <li>• In "Voltage and current operating ratings" table, updated maximum digital supply current</li> <li>• Updated "Voltage and current operating behaviors" table</li> <li>• Updated "Power mode transition operating behaviors" table</li> <li>• Updated "Power consumption operating behaviors" table</li> <li>• Updated "EMC radiated emissions operating behaviors for 64 LQFP package" table</li> <li>• Updated "Thermal attributes" table</li> <li>• Updated "MCG specifications" table</li> <li>• Updated "IRC48M specifications" table</li> <li>• Updated "16-bit ADC operating conditions" table</li> <li>• Updated "Voltage reference electrical specifications" section</li> </ul>
2	3/2014	Initial public release